

Notice of References Cited

Application/Control No.

10/653,990

Applicant(s)/Patent Under
Reexamination
SHEU ET AL.

Examiner

Jimmy Lin

Art Unit

1792

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0006558 A1	01-2002	Kobayashi et al.	430/7
*	B	US-2002/0112961 A1	08-2002	O'Connor et al.	204/601
*	C	US-2002/0124967 A1	09-2002	Sharp, Terrance M.	156/378
*	D	US-7,161,285 B2	01-2007	Okamoto et al.	313/311
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
*	U	English abstract of WO 02/41348; 5/23/2002			
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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